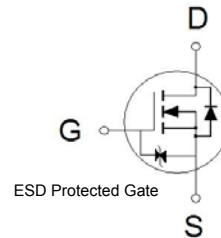


**NIKO-SEM****N-Channel Enhancement Mode  
Field Effect Transistor****PK5M6EA  
PDFN 5x6P  
Halogen-Free & Lead-Free****PRODUCT SUMMARY**

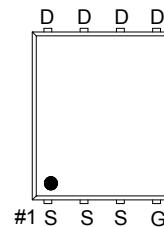
$V_{(BR)DSS}$	$R_{DS(on)}$	$I_D$
24V	5mΩ	59A

**Features**

- Pb-Free, Halogen Free and RoHS compliant.
- Low  $R_{DS(on)}$  to Minimize Conduction Losses.
- Ohmic Region Good  $R_{DS(on)}$  Ratio.
- Optimized Gate Charge to Minimize Switching Losses.
- Products Integrated ESD diode with ESD Protected.

**Applications**

- Protection Circuits Applications.
- Logic/Load Switch Circuits Applications.



G. GATE  
D. DRAIN  
S. SOURCE

100% UIS Tested  
100% Rg Tested

**ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$  Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		$V_{DS}$	24	V
Gate-Source Voltage		$V_{GS}$	$\pm 12$	V
Continuous Drain Current <sup>4</sup>	$T_C = 25^\circ\text{C}$	$I_D$	59	A
	$T_C = 100^\circ\text{C}$		37	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	120	
Continuous Drain Current	$T_A = 25^\circ\text{C}$	$I_D$	20	
	$T_A = 70^\circ\text{C}$		16	
Avalanche Current		$I_{AS}$	31	
Avalanche Energy	$L = 0.1\text{mH}$	$E_{AS}$	48	mJ
Power Dissipation	$T_C = 25^\circ\text{C}$	$P_D$	31	W
	$T_C = 100^\circ\text{C}$		12	
Power Dissipation <sup>3</sup>	$T_A = 25^\circ\text{C}$	$P_D$	3.5	W
	$T_A = 70^\circ\text{C}$		2.2	
Operating Junction & Storage Temperature Range		$T_j, T_{stg}$	-55 to 150	°C

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**THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient <sup>2</sup>	$t \leq 10s$	$R_{\theta JA}$		35	°C / W
Junction-to-Ambient <sup>2</sup>	Steady-State	$R_{\theta JA}$		58	
Junction-to-Case	Steady-State	$R_{\theta JC}$		4	

<sup>1</sup>Pulse width limited by maximum junction temperature.<sup>2</sup>The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ C$ .<sup>3</sup>The Power dissipation is based on  $R_{\theta JA} t \leq 10s$  value.<sup>4</sup>Package limitation current is 51A.**ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ C$ , Unless Otherwise Noted)**

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	24			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.7	0.9	1.3	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 10V$			$\pm 30$	$\mu A$
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 20V, V_{GS} = 0V$			1	$\mu A$
		$V_{DS} = 20V, V_{GS} = 0V, T_J = 55^\circ C$			10	
Drain-Source On-State Resistance <sup>1</sup>	$R_{DS(ON)}$	$V_{GS} = 2.5V, I_D = 10A$	5.6	8.5		$m\Omega$
		$V_{GS} = 4.5V, I_D = 10A$	3.9	5.5		
		$V_{GS} = 10V, I_D = 15A$	3.3	5		
Forward Transconductance <sup>1</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 15A$	76			S
<b>DYNAMIC</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = 12V, f = 1MHz$		1842		pF
Output Capacitance	$C_{oss}$			297		
Reverse Transfer Capacitance	$C_{rss}$			232		
Gate Resistance	$R_g$	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		1.8		$\Omega$
Total Gate Charge <sup>2</sup>	$Q_g$	$V_{GS} = 10V$		42		nC
				20		
Gate-Source Charge <sup>2</sup>	$Q_{gs}$	$V_{DS} = 12V, I_D = 15A$		2.2		nC
Gate-Drain Charge <sup>2</sup>	$Q_{gd}$			6.7		
Turn-On Delay Time <sup>2</sup>	$t_{d(on)}$	$V_{DS} = 12V,$ $I_D \geq 15A, V_{GS} = 10V, R_{GEN} = 6\Omega$		13		nS
Rise Time <sup>2</sup>	$t_r$			89		
Turn-Off Delay Time <sup>2</sup>	$t_{d(off)}$			77		
Fall Time <sup>2</sup>	$t_f$			136		

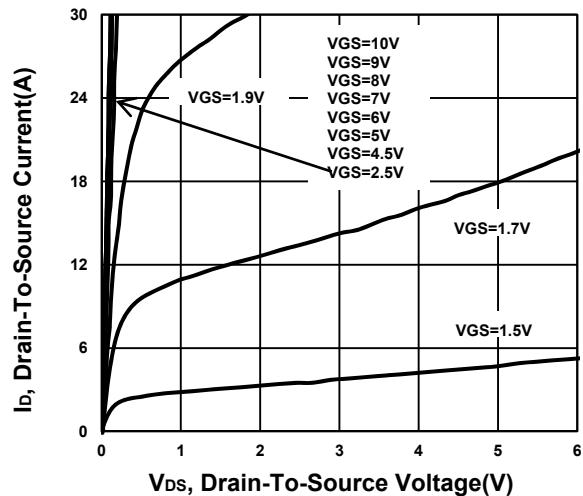
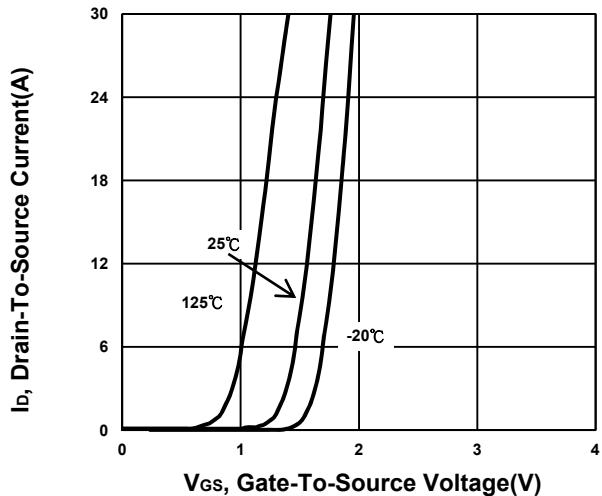
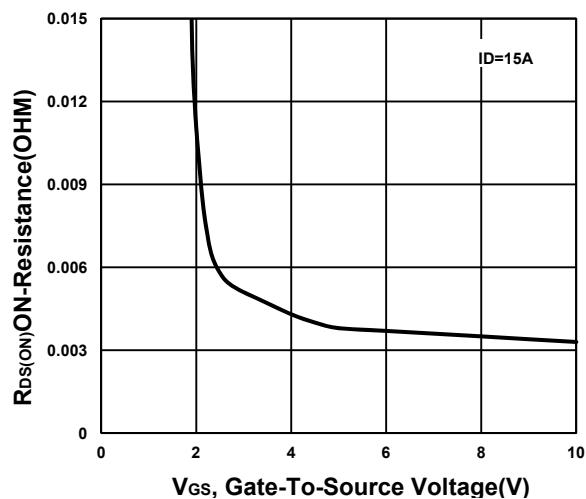
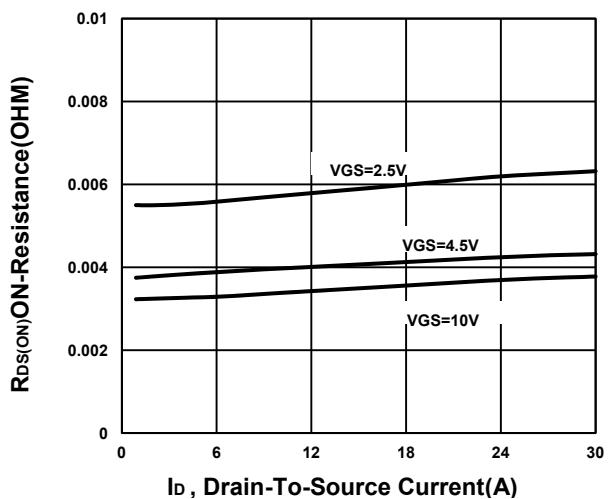
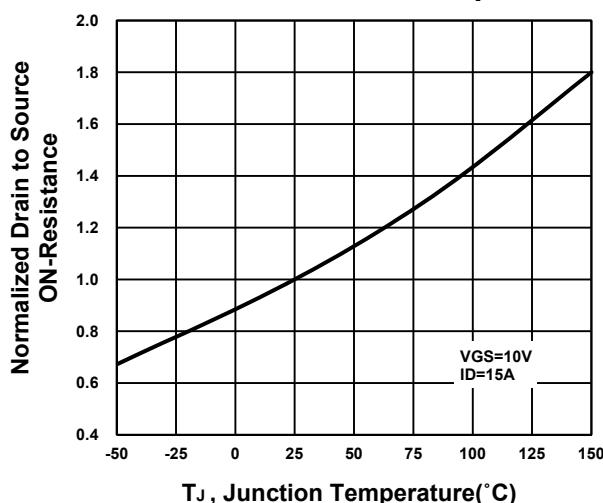
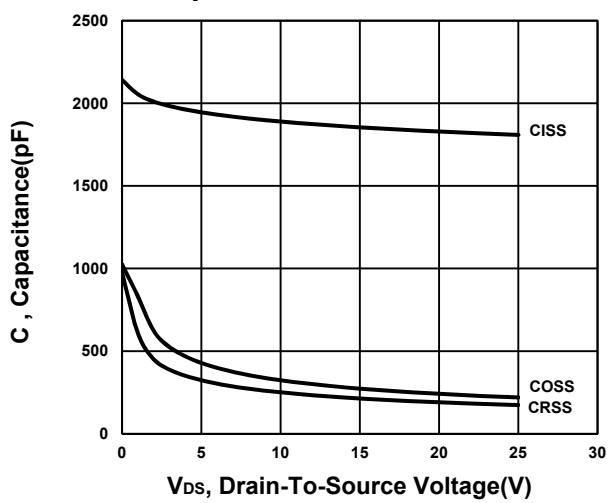
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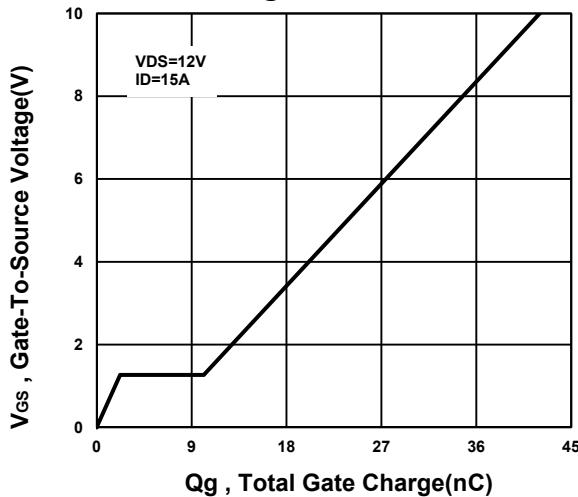
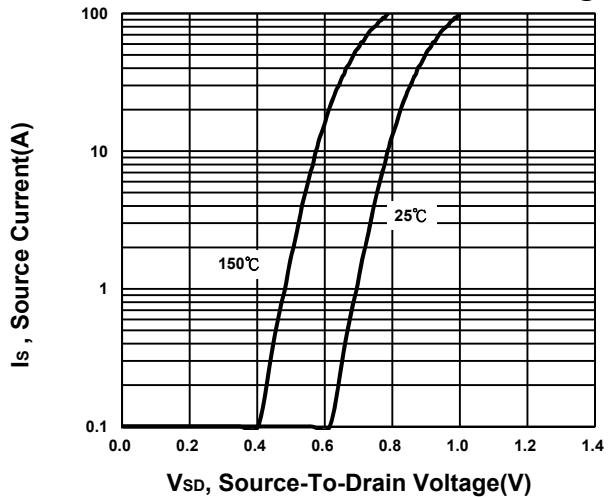
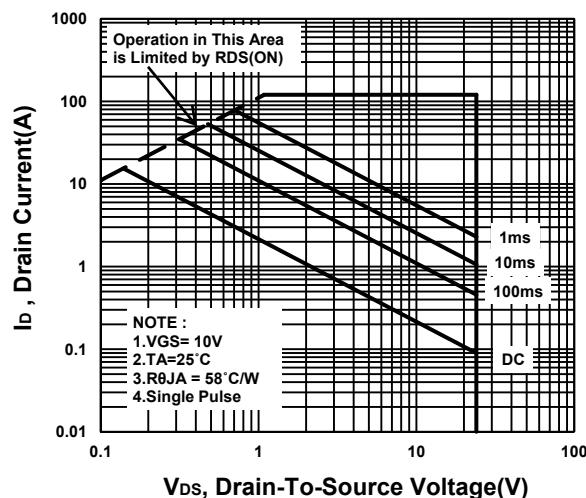
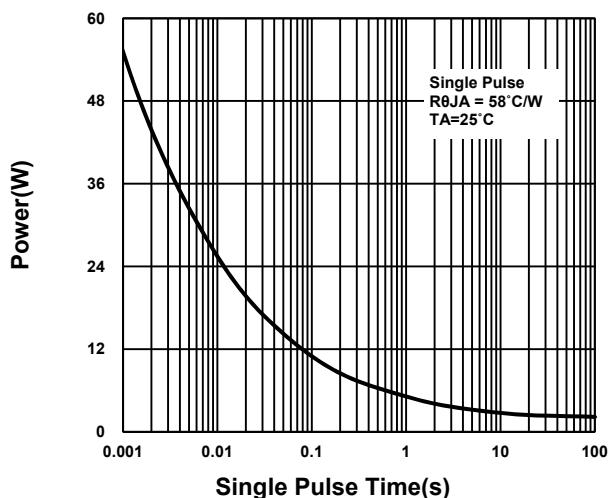
PDFN 5x6P

Halogen-Free &amp; Lead-Free

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ )						
Continuous Current	$I_S$				25	A
Forward Voltage <sup>1</sup>	$V_{SD}$	$I_F = 15\text{A}, V_{GS} = 0\text{V}$			1.2	V
Reverse Recovery Time	$t_{rr}$	$I_F = 15\text{A}, dI_F/dt = 100\text{A} / \mu\text{s}$		22		nS
Reverse Recovery Charge	$Q_{rr}$			7.7		nC

<sup>1</sup>Pulse test : Pulse Width  $\leq 300\ \mu\text{sec}$ , Duty Cycle  $\leq 2\%$ .<sup>2</sup>Independent of operating temperature.

**NIKO-SEM****N-Channel Enhancement Mode  
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Halogen-Free & Lead-Free****Output Characteristics****Transfer Characteristics****On-Resistance VS Gate-To-Source****On-Resistance VS Drain Current****On-Resistance VS Temperature****Capacitance Characteristic**

**NIKO-SEM****N-Channel Enhancement Mode  
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PDFN 5x6P  
Halogen-Free & Lead-Free****Gate charge Characteristics****Source-Drain Diode Forward Voltage****Safe Operating Area****Single Pulse Maximum Power Dissipation****Transient Thermal Response Curve**